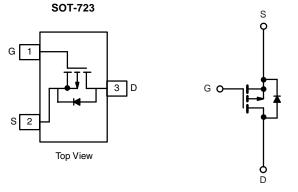
## P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A)	Q <sub>g</sub> (TYP.) (nC)			
	0.450 at $V_{GS}$ = -4.5 V	-0.55				
-20	0.500 at V <sub>GS</sub> = -2.5 V	-0.50	1			
	0.600 at V <sub>GS</sub> = -1.8 V	-0.38				



#### P-Channel MOSFET

## FEATURES

- TrenchFET<sup>®</sup> power MOSFET
- 100 % R tested
- Fast switching speed

#### **APPLICATIONS**

- Load / power switch for portable devices
- Drivers: relays, solenoids, displays
- Battery operated systems

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_A = 25 \text{ °C}$ , unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage		V <sub>DS</sub>	-20	V		
Gate-Source Voltage		V <sub>GS</sub>	± 8	- v		
Continuous Durain Current (T. 150 °C)	T <sub>A</sub> = 25 °C		-0.55 <sup>b, c</sup>			
Continuous Drain Current ( $T_J = 150 \ ^{\circ}C$ )	T <sub>A</sub> = 70 °C	I <sub>D</sub>	-0.45 <sup>b, c</sup>	A		
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	-1.8	A		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	-0.16 <sup>b, c</sup>			
Maximum Dawar Dissinction	T <sub>A</sub> = 25 °C	Р	0.19 <sup>b, c</sup>	W		
Maximum Power Dissipation	T <sub>A</sub> = 70 °C	P <sub>D</sub>	0.12 <sup>b, c</sup>	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C		

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum Junction-to-Ambient <sup>a, b</sup>	t ≤ 5 s	Р	440	530	°C/W		
Maximum Junction-to-Amplent 4, 2	Steady State	R <sub>thJA</sub>	540	650	0/10		

#### Notes

a. Maximum under steady state conditions is 650 °C/W.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.





PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0, I_D = -250 \ \mu A$	-20	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	L 050 ··· A	-	-12	-		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = -250 μA	-	1.8	-	mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$	-0.4	-	-1	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ± 8 V	-	-	± 30	1	
		$V_{DS} = 0 V, V_{GS} = \pm 4.5 V$ -		-	± 1		
Zero Gate Voltage Drain Current		$V_{DS}$ = -20 V, $V_{GS}$ = 0 V	-	-	-1	μΑ	
	IDSS	$V_{DS}$ = -20 V, $V_{GS}$ = 0 V, $T_J$ = 85 °C	-	-	-10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} = \ge 5 \text{ V},  V_{GS} = -4.5 \text{ V}$	-1.5	-	-	А	
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -0.4 \text{ A}$	-	0.450	-		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS}$ = -2.5 V, I <sub>D</sub> = -0.2 A	-	0.500	-	Ω	
	-	$V_{GS} = -1.8 \text{ V}, I_D = -0.1 \text{ A}$	-	0.600	-		
Forward Transconductance	<b>g</b> fs	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = 0.4 \text{ A}$	-	1	-	S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>		-	45	-	pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = -10 V, $V_{GS}$ = 0 V, f = 1 MHz	-	15	-		
Reverse Transfer Capacitance	C <sub>rss</sub>		-	10	-		
Tatal Cata Charge	0	$V_{DS}$ = -10 V, $V_{GS}$ = -4.5 V, $I_D$ = -0.4 A	-	1.65	2.50	- nC	
Total Gate Charge	Q <sub>g</sub>		-	1	2		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = -0 V, $V_{GS}$ = -2.5 V, $I_D$ = -0.4	-	0.2	-		
Gate-Drain Charge	Q <sub>gd</sub>		-	0.26	-		
Gate Resistance	Rg	f = 1 MHz	2.4	12	24	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>		-	9	18		
Rise Time	t <sub>r</sub>	$V_{DD}$ = -10 V, $R_L$ = 33.3 $\Omega$	-	10	20	-	
Turn-Off DelayTime	t <sub>d(off)</sub>	$\text{I}_\text{D}\cong$ -0.3 A, $\text{V}_\text{GEN}$ = -4.5 V, $\text{R}_\text{g}$ = 1 $\Omega$	-	10	20		
Fall Time	t <sub>f</sub>		-	8	16		
Turn-On Delay Time	t <sub>d(on)</sub>		-	1	2	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = -10 \text{ V}, \text{ R}_{L} = 33.3 \Omega$	-	8	16		
Turn-Off DelayTime	t <sub>d(off)</sub>	$\text{I}_\text{D}\cong$ -0.3 A, $\text{V}_\text{GEN}$ = -8 V, $\text{R}_\text{g}$ = 1 $\Omega$	-	9	18		
Fall Time	t <sub>f</sub>		-	5	10		
Drain-Source Body Diode Characteris	tics						
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>		-	-	-1.5	А	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = -0.3 A	-	-0.8	-1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	16	24	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		-	8	16	nC	
Reverse Recovery Fall Time	ta	I <sub>F</sub> = -0.3 A, dI/dt = 100 A/μs	-	11	-		
Reverse Recovery Rise Time	t <sub>b</sub>		-	5	_	ns	

#### Notes

a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$ 

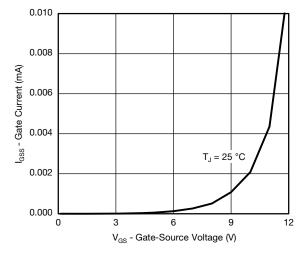
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

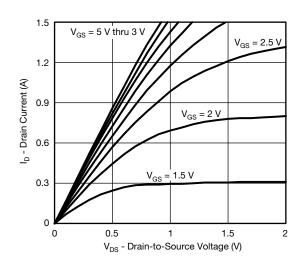
Bsemi



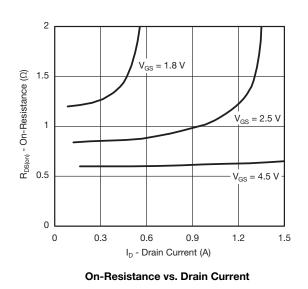
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Gate Current vs. Gate-Source Voltage

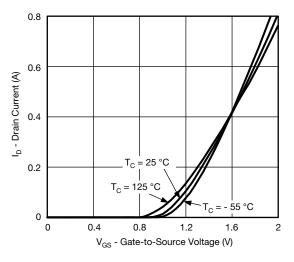


**Output Characteristics** 

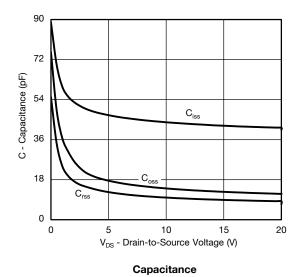


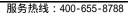
 $10^{-4}$   $10^{-5}$   $10^{-6}$   $10^{-7}$   $10^{-8}$   $0^{-8}$   $10^{-8}$   $0^{-$ 

Gate Current vs. Gate-Source Voltage

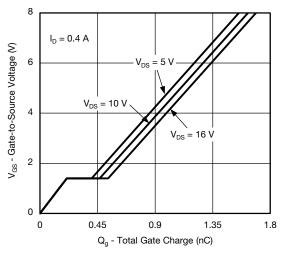






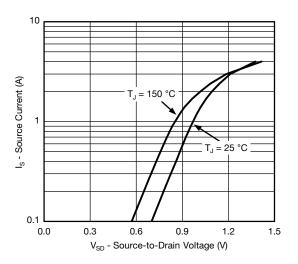




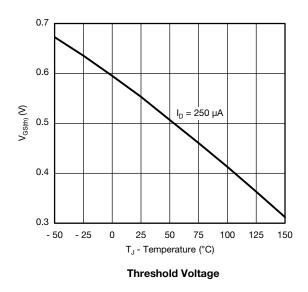


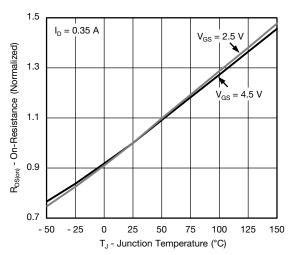
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



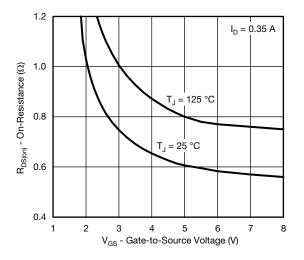


Source-Drain Diode Forward Voltage

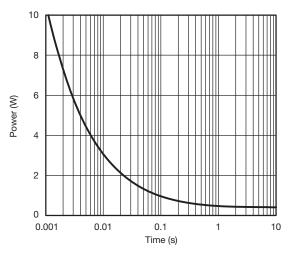




**On-Resistance vs. Junction Temperature** 

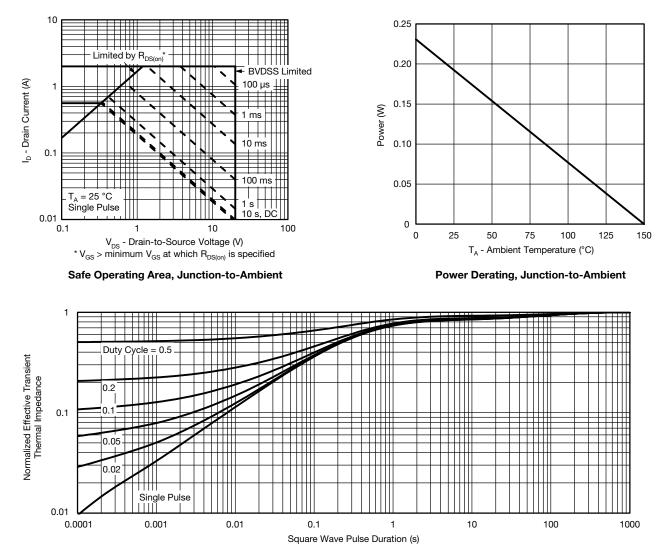


On-Resistance vs. Gate-to-Source Voltage







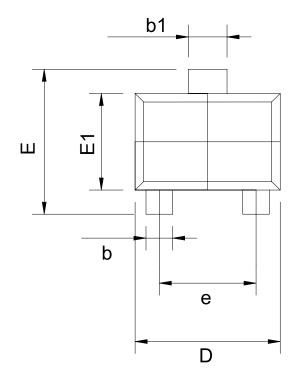


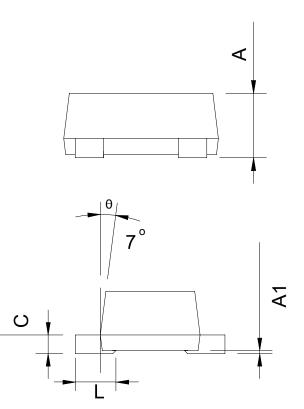
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Ambient



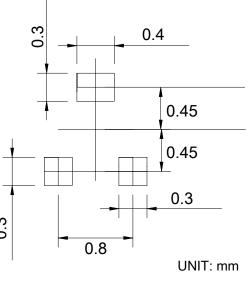
## SOT-723: 3 Leads





SYZBOL		RECOMM			
	MILLIMETERS		INC		
	MIN.	MAX.	MIN.	MAX.	
А	-	0.500	-	0.020	0.3
A1	0.000	0.050	0.000	0.002	
b	0.170	0.270	0.007	0.011	
b1	0.270	0.370	0.011	0.015	1 +
с	-	0.150	-	0.006	
D	1.150	1.250	0.045	0.049	
Е	1.150	1.250	0.045	0.049	
E1	0.750	0.850	0.030	0.033	
е	0.800 TYP.		0.031 TYP.		
L	0.32 BSC		0.01	3 BSC	0.3
_	° F	REF.	°	REF.	







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